Small, Low Power, 3-Axis ±3 *g* *i*MEMS® Accelerometer

ADXL330

FEATURES

- **3-axis sensing**
- **Small, low-profile package**
  - **4 mm × 4 mm × 1.45 mm LFCSP**
- **Low power**
  - **200 μA at V_S = 2.0 V (typical)**
- **Single-supply operation**
  - **2.0 V to 3.6 V**
- **10,000 *g* shock survival**
- **Excellent temperature stability**
- **BW adjustment with a single capacitor per axis**
- **RoHS/WEEE lead-free compliant**

APPLICATIONS

- **Cost-sensitive, low power, motion- and tilt-sensing applications**
  - **Mobile devices**
  - **Gaming systems**
  - **Disk drive protection**
  - **Image stabilization**
  - **Sports and health devices**

GENERAL DESCRIPTION

The ADXL330 is a small, thin, low power, complete three axis accelerometer with signal conditioned voltage outputs, all on a single monolithic IC. The product measures acceleration with a minimum full-scale range of ±3 *g*. It can measure the static acceleration of gravity in tilt-sensing applications, as well as dynamic acceleration resulting from motion, shock, or vibration.

The user selects the bandwidth of the accelerometer using the C_X, C_Y, and C_Z capacitors at the X_{OUT}, Y_{OUT}, and Z_{OUT} pins. Bandwidths can be selected to suit the application, with a range of 0.5 Hz to 1,600 Hz for X and Y axes, and a range of 0.5 Hz to 550 Hz for the Z axis.

The ADXL330 is available in a small, low-profile, 4 mm × 4 mm × 1.45 mm, 16-lead, plastic lead frame chip scale package (LFCSP_LQ).

FUNCTIONAL BLOCK DIAGRAM

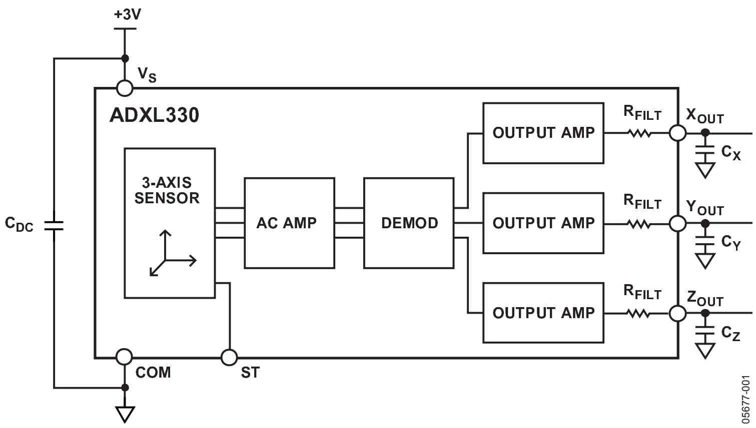

Figure 1.

Rev. 0

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SPECIFICATIONS

T_A = 25°C, V_S = 3 V, $C_X = C_Y = C_Z$ = 0.1 µF, acceleration = 0 *g*, unless otherwise noted. All minimum and maximum specifications are guaranteed. Typical specifications are not guaranteed.

Table 1.

Parameter	Conditions	Min	Typ	Max	Unit
SENSOR INPUT	Each axis				
Measurement Range		±3	±3.6		*g*
Nonlinearity	% of full scale		±0.3		%
Package Alignment Error			±1		Degrees
Inter-Axis Alignment Error			±0.1		Degrees
Cross Axis Sensitivity[1]			±1		%
SENSITIVITY (RATIOMETRIC)[2]	Each axis				
Sensitivity at X_{OUT}, Y_{OUT}, Z_{OUT}	V_S = 3 V	270	300	330	mV/*g*
Sensitivity Change Due to Temperature[3]	V_S = 3 V		±0.015		%/°C
ZERO *g* BIAS LEVEL (RATIOMETRIC)	Each axis				
0 *g* Voltage at X_{OUT}, Y_{OUT}, Z_{OUT}	V_S = 3 V	1.2	1.5	1.8	V
0 *g* Offset vs. Temperature			±1		m*g*/°C
NOISE PERFORMANCE					
Noise Density X_{OUT}, Y_{OUT}			280		µ*g*/√Hz rms
Noise Density Z_{OUT}			350		µ*g*/√Hz rms
FREQUENCY RESPONSE[4]					
Bandwidth X_{OUT}, Y_{OUT}[5]	No external filter		1600		Hz
Bandwidth Z_{OUT}[5]	No external filter		550		Hz
R_{FILT} Tolerance			32 ± 15%		kΩ
Sensor Resonant Frequency			5.5		kHz
SELF-TEST[6]					
Logic Input Low			+0.6		V
Logic Input High			+2.4		V
ST Actuation Current			+60		µA
Output Change at X_{OUT}	Self-test 0 to 1		−150		mV
Output Change at Y_{OUT}	Self-test 0 to 1		+150		mV
Output Change at Z_{OUT}	Self-test 0 to 1		−60		mV
OUTPUT AMPLIFIER					
Output Swing Low	No load		0.1		V
Output Swing High	No load		2.8		V
POWER SUPPLY					
Operating Voltage Range		2.0		3.6	V
Supply Current	V_S = 3 V		320		µA
Turn-On Time[7]	No external filter		1		ms
TEMPERATURE					
Operating Temperature Range		−25		+70	°C

[1] Defined as coupling between any two axes.
[2] Sensitivity is essentially ratiometric to V_S.
[3] Defined as the output change from ambient-to-maximum temperature or ambient-to-minimum temperature.
[4] Actual frequency response controlled by user-supplied external filter capacitors (C_X, C_Y, C_Z).
[5] Bandwidth with external capacitors = 1/(2 × π × 32 kΩ × C). For C_X, C_Y = 0.003 µF, bandwidth = 1.6 kHz. For C_Z = 0.01 µF, bandwidth = 500 Hz. For C_X, C_Y, C_Z = 10 µF, bandwidth = 0.5 Hz.
[6] Self-test response changes cubically with V_S.
[7] Turn-on time is dependent on C_X, C_Y, C_Z and is approximately 160 × C_X or C_Y or C_Z + 1 ms, where C_X, C_Y, C_Z are in µF.

APPLICATIONS

POWER SUPPLY DECOUPLING

For most applications, a single 0.1 µF capacitor, C_{DC}, placed close to the ADXL330 supply pins adequately decouples the accelerometer from noise on the power supply. However, in applications where noise is present at the 50 kHz internal clock frequency (or any harmonic thereof), additional care in power supply bypassing is required as this noise can cause errors in acceleration measurement. If additional decoupling is needed, a 100 Ω (or smaller) resistor or ferrite bead can be inserted in the supply line. Additionally, a larger bulk bypass capacitor (1 µF or greater) can be added in parallel to C_{DC}. Ensure that the connection from the ADXL330 ground to the power supply ground is low impedance because noise transmitted through ground has a similar effect as noise transmitted through V_S.

SETTING THE BANDWIDTH USING C_X, C_Y, AND C_Z

The ADXL330 has provisions for band limiting the X_{OUT}, Y_{OUT}, and Z_{OUT} pins. Capacitors must be added at these pins to implement low-pass filtering for antialiasing and noise reduction. The equation for the 3 dB bandwidth is

$$F_{-3\ dB} = 1/(2\pi(32\ k\Omega) \times C_{(X,\ Y,\ Z)})$$

or more simply

$$F_{-3\ dB} = 5\ \mu F/C_{(X,\ Y,\ Z)}$$

The tolerance of the internal resistor (R_{FILT}) typically varies as much as ±15% of its nominal value (32 kΩ), and the bandwidth varies accordingly. A minimum capacitance of 0.0047 µF for C_X, C_Y, and C_Z is recommended in all cases.

Table 5. Filter Capacitor Selection, C_X, C_Y, and C_Z

Bandwidth (Hz)	Capacitor (µF)
1	4.7
10	0.47
50	0.10
100	0.05
200	0.027
500	0.01

SELF-TEST

The ST pin controls the self-test feature. When this pin is set to V_S, an electrostatic force is exerted on the accelerometer beam. The resulting movement of the beam allows the user to test if the accelerometer is functional. The typical change in output is −500 m*g* (corresponding to −150 mV) in the X-axis, 500 m*g* (or 150 mV) on the Y-axis, and −200 m*g* (or −60 mV) on the Z-axis. This ST pin may be left open circuit or connected to common (COM) in normal use.

Never expose the ST pin to voltages greater than V_S + 0.3 V. If this cannot be guaranteed due to the system design (for instance, if there are multiple supply voltages), then a low V_F clamping diode between ST and V_S is recommended.

DESIGN TRADE-OFFS FOR SELECTING FILTER CHARACTERISTICS: THE NOISE/BW TRADE-OFF

The selected accelerometer bandwidth ultimately determines the measurement resolution (smallest detectable acceleration). Filtering can be used to lower the noise floor to improve the resolution of the accelerometer. Resolution is dependent on the analog filter bandwidth at X_{OUT}, Y_{OUT}, and Z_{OUT}.

The output of the ADXL330 has a typical bandwidth of greater than 500 Hz. The user must filter the signal at this point to limit aliasing errors. The analog bandwidth must be no more than half the analog-to-digital sampling frequency to minimize aliasing. The analog bandwidth can be further decreased to reduce noise and improve resolution.

The ADXL330 noise has the characteristics of white Gaussian noise, which contributes equally at all frequencies and is described in terms of µ*g*/√Hz (the noise is proportional to the square root of the accelerometer bandwidth). The user should limit bandwidth to the lowest frequency needed by the application to maximize the resolution and dynamic range of the accelerometer.

With the single-pole, roll-off characteristic, the typical noise of the ADXL330 is determined by

$$rms\ Noise = Noise\ Density \times (\sqrt{BW \times 1.6})$$

Often, the peak value of the noise is desired. Peak-to-peak noise can only be estimated by statistical methods. Table 6 is useful for estimating the probabilities of exceeding various peak values, given the rms value.

Table 6. Estimation of Peak-to-Peak Noise

Peak-to-Peak Value	% of Time that Noise Exceeds Nominal Peak-to-Peak Value
2 × rms	32
4 × rms	4.6
6 × rms	0.27
8 × rms	0.006

USE WITH OPERATING VOLTAGES OTHER THAN 3 V

The ADXL330 is tested and specified at V_S = 3 V; however, it can be powered with V_S as low as 2 V or as high as 3.6 V. Note that some performance parameters change as the supply voltage is varied.

The ADXL330 output is ratiometric, therefore, the output sensitivity (or scale factor) varies proportionally to the supply voltage. At V_S = 3.6 V, the output sensitivity is typically 360 mV/*g*. At V_S = 2 V, the output sensitivity is typically 195 mV/*g*.

The zero *g* bias output is also ratiometric, so the zero *g* output is nominally equal to $V_S/2$ at all supply voltages.

The output noise is not ratiometric but is absolute in volts; therefore, the noise density decreases as the supply voltage increases. This is because the scale factor (mV/*g*) increases while the noise voltage remains constant. At V_S = 3.6 V, the X- and Y-axis noise density is typically 230 μ*g*/√Hz, while at V_S = 2 V, the X- and Y-axis noise density is typically 350 μ*g*/√Hz.

Self-test response in *g* is roughly proportional to the square of the supply voltage. However, when ratiometricity of sensitivity is factored in with supply voltage, the self-test response in volts is roughly proportional to the cube of the supply voltage. For example, at V_S = 3.6 V, the self-test response for the ADXL330 is approximately −275 mV for the X-axis, +275 mV for the Y-axis, and −100 mV for the Z-axis.

At V_S = 2 V, the self-test response is approximately −60 mV for the X-axis, +60 mV for the Y-axis, and −25 mV for the Z-axis.

The supply current decreases as the supply voltage decreases. Typical current consumption at V_S = 3.6 V is 375 μA, and typical current consumption at V_S = 2 V is 200 μA.

AXES OF ACCELERATION SENSITIVITY

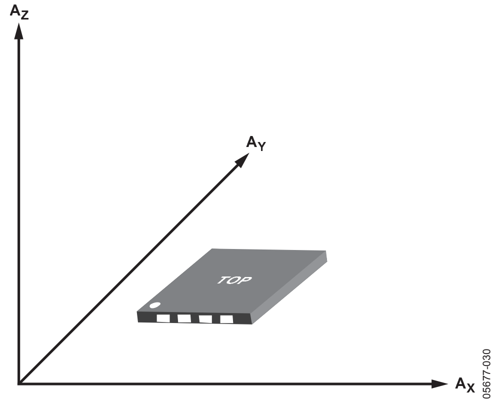

Figure 31. Axes of Acceleration Sensitivity, Corresponding Output Voltage Increases When Accelerated Along the Sensitive Axis

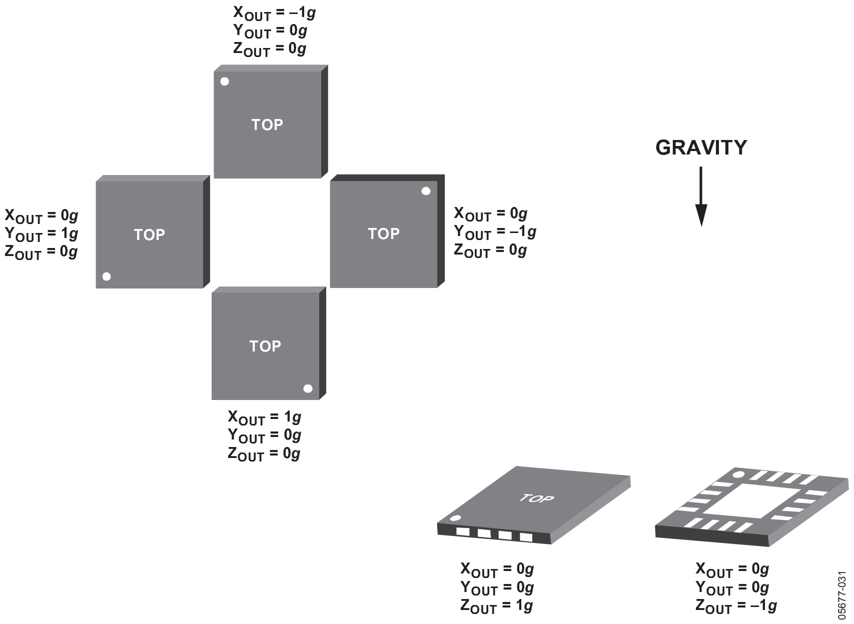

Figure 32. Output Response vs. Orientation to Gravity